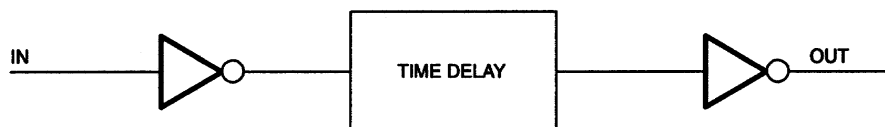


**LOGIC DIAGRAM** Figure 1

ONE OF THREE

**PART NUMBER DELAY TABLE** ( $t_{PLH}$ ,  $t_{PHL}$ ) Table 1

PART NUMBER	DELAY PER OUTPUT (ns) (note 1)	INITIAL TOLERANCE (note 1)	TOLERANCE OVER TEMPERATURE AND VOLTAGE (note 2)	
			$V_{CC}=3.3V \pm 0.3V$	$V_{CC}=2.7V$
DS1033-8	8/8/8	$\pm 1.5$ ns	$\pm 1.0$ ns	$\pm 1.5$ ns
DS1033-10	10/10/10	$\pm 1.5$ ns	$\pm 1.0$ ns	$\pm 1.5$ ns
DS1033-12	12/12/12	$\pm 1.5$ ns	$\pm 1.0$ ns	$\pm 1.5$ ns
DS1033-15	15/15/15	$\pm 1.5$ ns	$\pm 1.5$ ns	$\pm 2.0$ ns
DS1033-20	20/20/20	$\pm 1.5$ ns	$\pm 1.5$ ns	$\pm 2.5$ ns
DS1033-25	25/25/25	$\pm 2.0$ ns	$\pm 2.0$ ns	$\pm 3.5$ ns
DS1033-30	30/30/30	$\pm 2.0$ ns	$\pm 2.0$ ns	$\pm 5.0$ ns

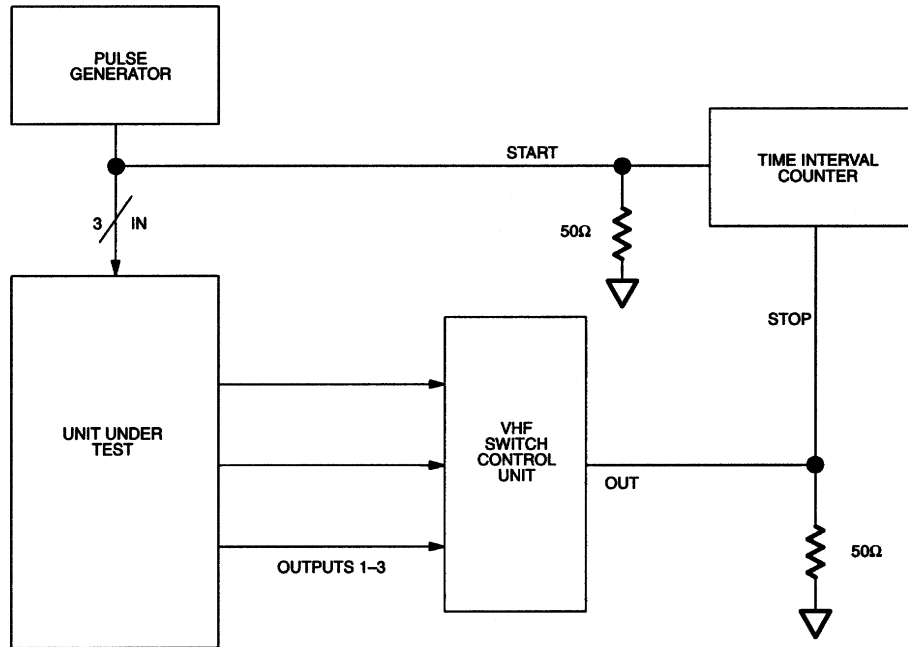
**NOTES:**

1. Nominal conditions are  $+25^{\circ}\text{C}$  and  $V_{CC}=+3.3$  volts.
2. Temperature range of  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .
3. Delay accuracy is for both leading and trailing edges.

## TEST SETUP DESCRIPTION

Figure 2 illustrates the hardware configuration used for measuring the timing parameters of the DS1033. The input waveform is produced by a precision pulse generator under software control. Time delays are measured by a time interval counter (20 ps resolution) connected to the output. The DS1033 output taps are selected and connected to the interval counter by a VHF switch control unit. All measurements are fully automated with each instrument controlled by the computer over an IEEE 488 bus.

### DS1033 TEST CIRCUIT Figure 2



**ABSOLUTE MAXIMUM RATINGS\***

Voltage on Any Pin Relative to Ground	-1.0V to +6.0V
Operating Temperature	0°C to 70°C
Storage Temperature	-55°C to +125°C
Soldering Temperature	260°C for 10 seconds
Short Circuit Output Current	50 mA for 1 second

\* This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

**DC ELECTRICAL CHARACTERISTICS**(T<sub>A</sub> = 0°C to 70°C)

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
Supply Voltage	V <sub>CC</sub>		2.7	3.3	3.6	V
Active Current	I <sub>CC</sub>	V <sub>CC</sub> =3.6V Period=1μs			25	mA
High Level Input Voltage	V <sub>IH</sub>		2.0		V <sub>CC</sub> +0.5	V
Low Level Input Voltage	V <sub>IL</sub>		-0.5		0.8	V
Input Leakage	I <sub>L</sub>	0V ≤ V <sub>I</sub> ≤ V <sub>CC</sub>	-1.0		1.0	μA
High Level Output Current	I <sub>OH</sub>	V <sub>CC</sub> =2.7V V <sub>OH</sub> =2V			-1.0	mA
Low Level Output Current	I <sub>OL</sub>	V <sub>CC</sub> =2.7V V <sub>OL</sub> =0.4V	8			mA

**AC ELECTRICAL CHARACTERISTICS**(T<sub>A</sub> = +25°C)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Period	t <sub>PERIOD</sub>	2 (twi)			ns	2
Input Pulse Width	t <sub>WI</sub>	100% of Tap Delay			ns	2
Input-to-Tap Output Delay	t <sub>PLH</sub> , t <sub>PHL</sub>		Table 1		ns	
Output Rise or Fall Time	t <sub>OR</sub> , t <sub>OF</sub>		2.0	2.5	ns	3
			3.0	3.5	ns	4
Power-up Time	t <sub>PU</sub>			100	ms	

**CAPACITANCE**(T<sub>A</sub> = +25°C)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Capacitance	C <sub>IN</sub>			10	pF	

## TEST CONDITIONS

Ambient Temperature:  $25^{\circ}\text{C} \pm 3^{\circ}\text{C}$

Supply Voltage ( $V_{\text{CC}}$ ):  $3.3\text{V} \pm 0.1\text{V}$

Input Pulse:

High:  $3.0\text{V} \pm 0.1\text{V}$

Low:  $0.0\text{V} \pm 0.1\text{V}$

Source Impedance:  $50\Omega$  max.

Rise and Fall Time:  $3.0\text{ ns max.}$  - Measured between  $0.6\text{V}$  and  $2.4\text{V}$ .

Pulse Width:  $500\text{ ns}$

Pulse Period:  $1\text{ }\mu\text{s}$

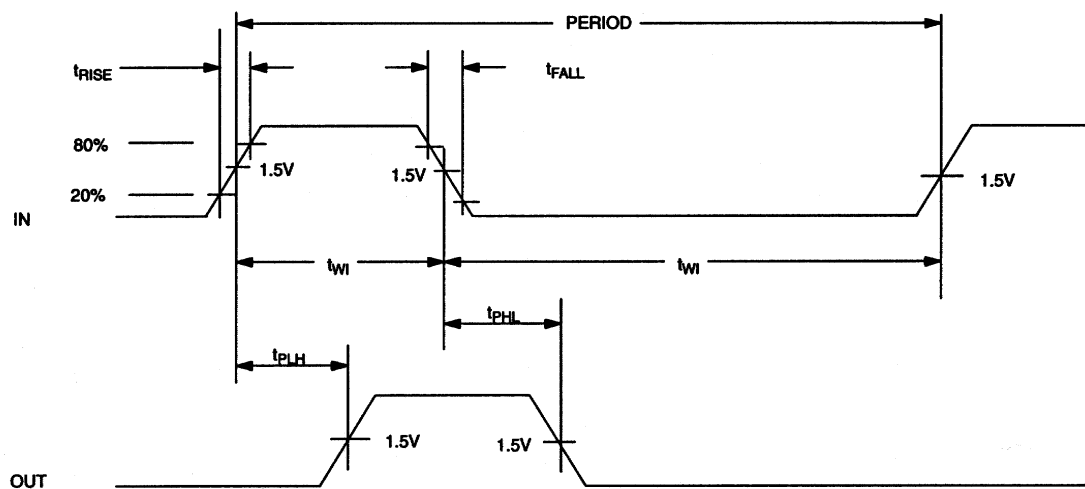
Output Load Capacitance:  $15\text{ pF}$

Output: Each output is loaded with the equivalent of one 74F04 input gate.

Data is measured at the  $1.5\text{V}$  level on the rising and falling edges.

**Note:** The above conditions are for test only and do not restrict the devices under other data sheet conditions.

## TIMING DIAGRAM



## NOTES:

1. All voltages are referenced to ground.
2. Pulse width and duty cycle specifications may be exceeded; however, accuracy will be application-sensitive with respect to de-coupling, layout, etc.
3.  $V_{\text{CC}}=3.3\text{V} \pm 10\%$ .
4.  $V_{\text{CC}}=2.7\text{V}$ .

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## TERMINOLOGY

**Period:** The time elapsed between the leading edge of the first pulse and the leading edge of the following pulse.

**$t_{WI}$** (Pulse Width): The elapsed time on the pulse between the 1.5 volt point on the leading edge and the 1.5 volt point on the trailing edge, or the 1.5 volt point on the trailing edge and the 1.5 volt point on the leading edge.

**$t_{RISE}$** (Input Rise Time): The elapsed time between the 20% and the 80% point on the leading edge of the input pulse.

**$t_{FALL}$** (Input Fall Time): The elapsed time between the 80% and the 20% point on the trailing edge on the input pulse.

**$t_{PLH}$** (Time Delay, Rising): The elapsed time between the 1.5 volt point on the leading edge of the input pulse and the 1.5 volt point on the leading edge of the output pulse.

**$t_{PHL}$** (Time Delay, Falling): The elapsed time between the 1.5 volt point on the falling edge of the input pulse and the 1.5 volt point on the falling edge of the output pulse.

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